Joint ICTP-IAEA School on Novel Experimental Methodologies for Synchrotron Radiation Applications in Nano-science and Environmental Monitoring | (smr 2611)

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Evaluation of XRF spectra: from basics to advanced systems

Thursday, 20 November 2014 14:30 (1:00)

Content

Summary

 $\label{eq:presenter} \textbf{Presenter(s)}: \quad \text{P. VAN ESPEN (University of Antwerpen - Belgium)}$

Session Classification: not yet classified